

# SVT Beam Accident Analysis

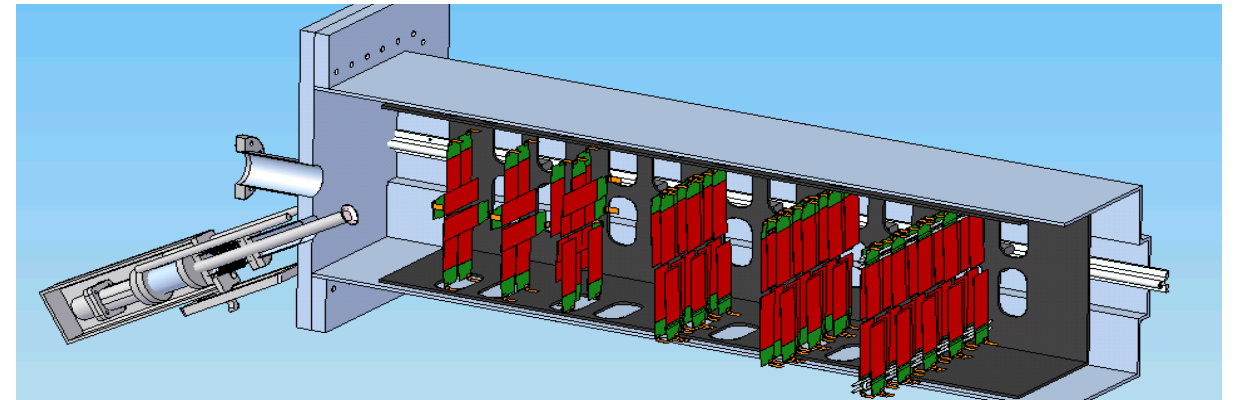
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*Tim Nelson* - **SLAC**

May 8, 2015

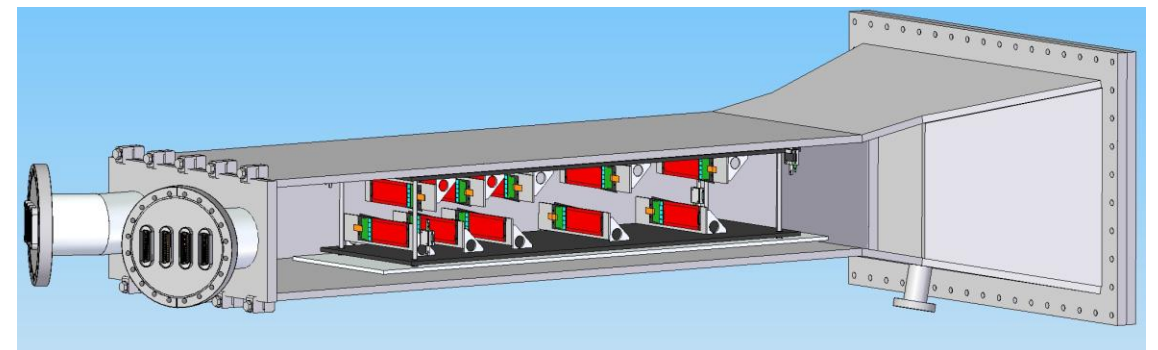
# HPS Target History

## *2010 proposal*



- The tracker measured x-y equally well. (We assumed a bigger magnet)
- The beam spot was circular and smaller (10 microns) to take advantage of this
- In proposal, it was said we would melt the target ( $>1000\text{ }^{\circ}\text{C}$ ) in 7 ms at 450 nA.

## *2011 proposal*



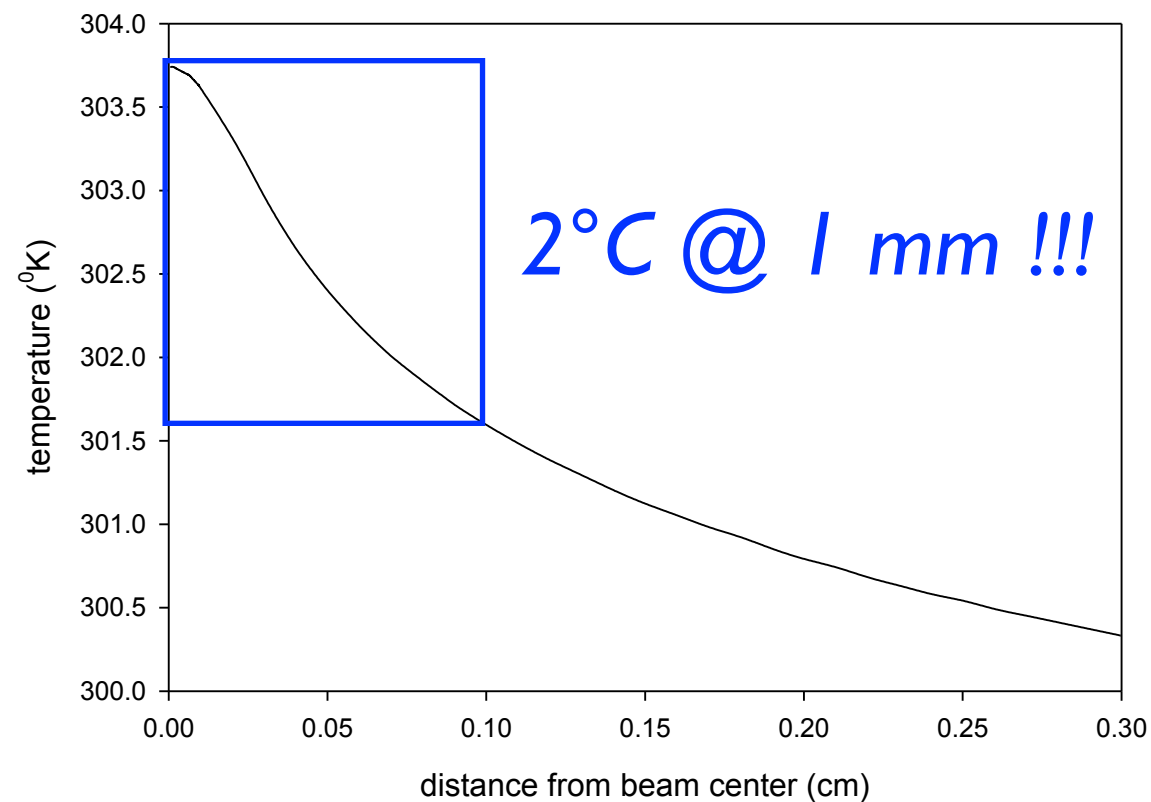
- To use PS magnet/chamber and existing sensors, tracker measures y better than x.
- Beam spot can be larger in x: designed at  $20\text{ }\mu\text{m} \times 250\text{ }\mu\text{m}$  to avoid destroying target.

*These designs assumed heat loss only by radiation!!*

# Conduction is Critical

- Temperature profile as calculated for tungsten at 600 nA by an iterative code:

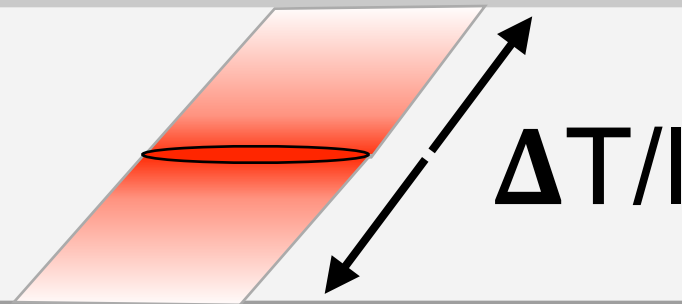
HPS tungsten target 4 microns thick:  
beam 600 nA, circular spot  $\phi = 122 \mu\text{m}$ ,  
1 sec exposure with conductive and radiative cooling.



Clive Field  
@ Jan. 2014  
Collaboration  
Meeting

# Toy Calculation for Target

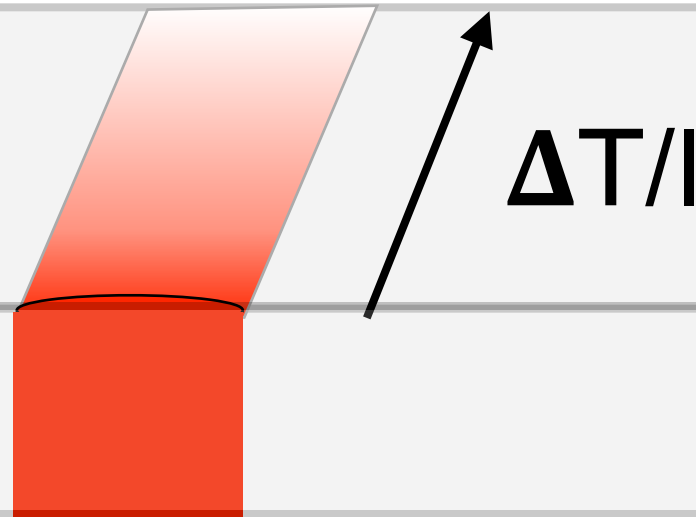
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- 50 nA beam strikes target, 4 microns thick.
- Power is applied to a plane inside the target silicon 300 microns wide. (320 microns X 4 microns)
- Assume heat must flow through target perpendicular to that surface. In reality, it spreads radially outward, but gives an idea what the drops are.
  - Collisional energy loss in silicon for electrons  $dE/dx = 1.6 \text{ MeV cm}^2 / \text{g}$
  - Power =  $19.25 \text{ (g/cm}^3) \cdot .0004 \text{ cm} \cdot 1.6 \text{ MeV cm}^2/\text{g} \cdot 50 \times 10^{-9} \text{ A} / 1.6 \times 10^{-19} \text{ C} = 616 \text{ } \mu\text{W}$
  - $\Delta T/l = (6.2 \times 10^{-4} \text{ W}) / (173 \text{ W/m-}^\circ\text{K}) / (2 \cdot 0.0003 \text{ m} \cdot 0.000004 \text{ m}) = 1.5 \text{ } ^\circ\text{K} / \text{mm}$
- Temperature rise is very small, generally agrees with Clive's simulation.

# Toy Calculation for Silicon

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- 5 nA beam grazes silicon edge, 320 microns thick. Since this is  $\sim 3X$  thicker than our target, should raise FSD counter rates by  $\sim 30\%$ .
- Power is applied to a surface along the edge of the silicon 300 microns wide. (320 microns  $\times$  300 microns)
- Assume heat must flow through silicon perpendicular to that surface. In reality, it spreads radially outward, but gives an idea what the drops are.
  - Collisional energy loss in silicon for electrons  $dE/dx = 2.1 \text{ MeV cm}^2 / \text{g}$
  - Power =  $2.33 \text{ (g/cm}^3) \cdot .032 \text{ cm} \cdot 2.1 \text{ MeV cm}^2/\text{g} \cdot 5 \times 10^{-9} \text{ A} / 1.6 \times 10^{-19} \text{ C} = 784 \text{ } \mu\text{W}$
  - $\Delta T / l = (7.8 \times 10^{-4} \text{ W}) / (149 \text{ W/m-}^\circ\text{K}) / (0.0003 \text{ m} \cdot 0.00032 \text{ m}) = 0.054 \text{ } ^\circ\text{K} / \text{mm}$
- Temperature rise is negligible.

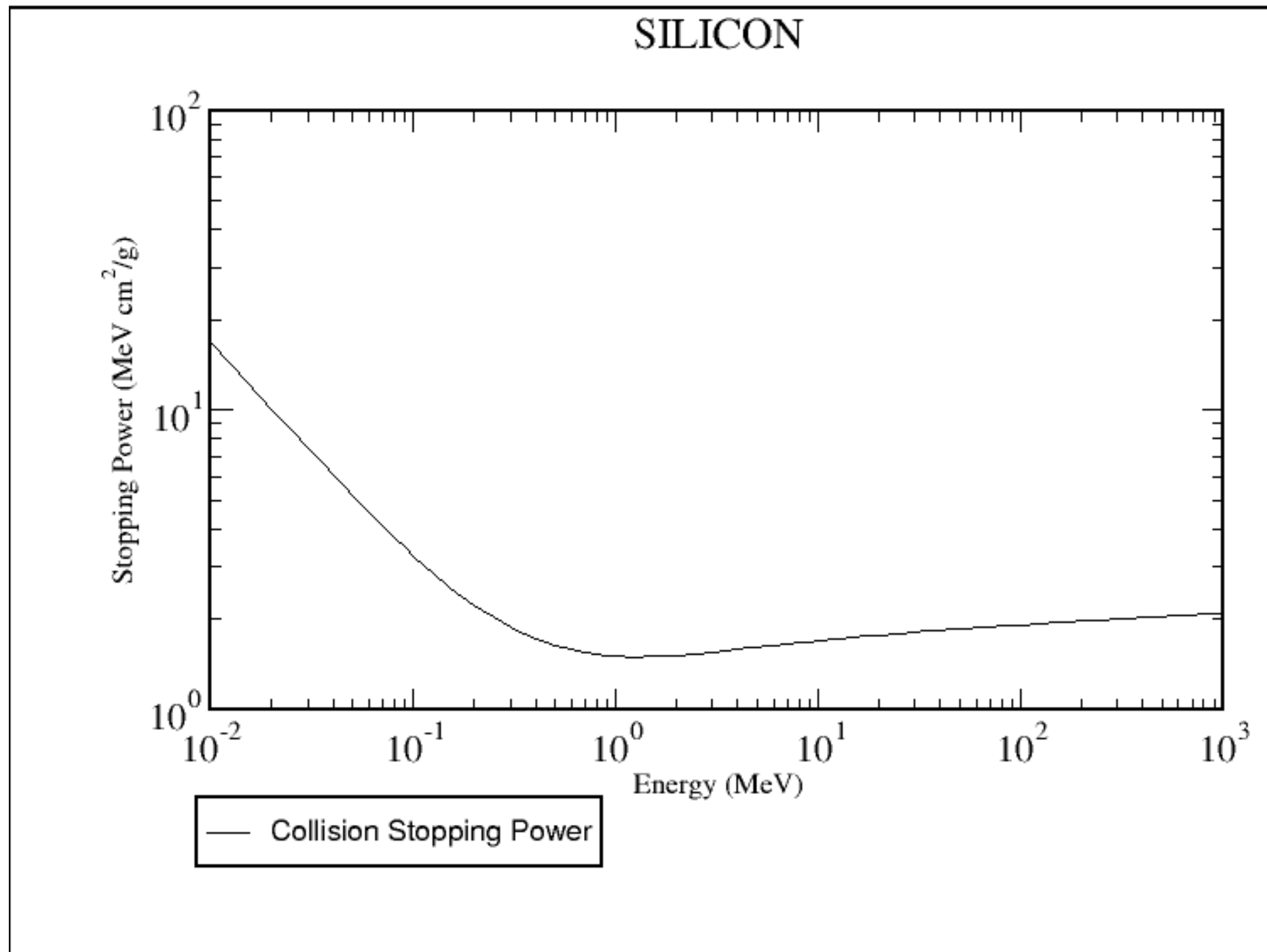
# Conclusion

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- No danger of acute mechanical damage from beam strike. (Also no danger of melting the target with any beam that could be generated in Hall B).
- *Significant* beam dwelling continuously on silicon will lead to extreme radiation damage with unpredictable results, so it is best avoided.
- *Full* beam dwelling on silicon can also contribute to thermal runaway, so again... best avoided.
- FSD is still important, but there is little hazard of a beam accident destroying an entire sensor.

# Silicon Stopping Power

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# Tungsten Stopping Power

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